



An Infineon Technologies Company

# IRFE9130

## JANTX2N6849U

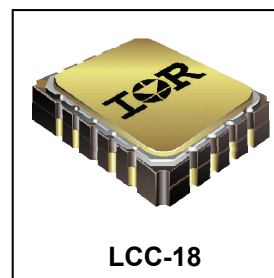
## JANTXV2N6849U

### REPETITIVE AVALANCHE AND $dv/dt$ RATED HEXFET<sup>®</sup> TRANSISTORS

100V, P-CHANNEL  
REF: MIL-PRF-19500/564

#### Product Summary

Part Number	BVDSS	RDS(on)	I <sub>D</sub>
IRFE9130	-100V	0.30Ω	-6.5A



#### Description

The leadless chip carrier (LCC) package represents the logical next step in the continual evolution of surface mount technology. Designed to be a close replacement for the TO-39 package, the LCC will give designers the extra flexibility they need to increase circuit board density. IR HiRel has engineered the LCC package to meet the specific needs of the power market by increasing the size of the bottom source pad, thereby enhancing the thermal and electrical performance. The lid of the package is grounded to the source to reduce RF interference.

#### Features

- Surface Mount
- Small Footprint
- Alternative to TO-39 Package
- Hermetically Sealed
- Dynamic  $dv/dt$  Rating
- Avalanche Energy Rating
- Simple Drive Requirements
- Light Weight
- ESD Rating: Class 1C per MIL-STD-750, Method 1020

#### Absolute Maximum Ratings

Symbol	Parameter	Value	Units
I <sub>D1</sub> @ V <sub>GS</sub> = -10V, T <sub>C</sub> = 25°C	Continuous Drain Current	-6.5	A
I <sub>D2</sub> @ V <sub>GS</sub> = -10V, T <sub>C</sub> = 100°C	Continuous Drain Current	-4.1	
I <sub>DM</sub> @ T <sub>C</sub> = 25°C	Pulsed Drain Current ①	-25	
P <sub>D</sub> @ T <sub>C</sub> = 25°C	Maximum Power Dissipation	25	W
	Linear Derating Factor	0.20	W/°C
V <sub>GS</sub>	Gate-to-Source Voltage	± 20	V
E <sub>AS</sub>	Single Pulse Avalanche Energy ②	165	mJ
I <sub>AR</sub>	Avalanche Current ①	-6.5	A
E <sub>AR</sub>	Repetitive Avalanche Energy ①	2.5	mJ
dv/dt	Peak Diode Recovery dv/dt ③	-5.5	V/ns
T <sub>J</sub> T <sub>STG</sub>	Operating Junction and Storage Temperature Range	-55 to + 150	°C
	Package Mounting Surface Temp.	300 (for 5 s)	
	Weight	0.42 (Typical)	

For Footnotes, refer to the page 2.

### Electrical Characteristics @ T<sub>j</sub> = 25°C (Unless Otherwise Specified)

Symbol	Parameter	Min.	Typ.	Max.	Units	Test Conditions
BV <sub>DSS</sub>	Drain-to-Source Breakdown Voltage	-100	—	—	V	V <sub>GS</sub> = 0V, I <sub>D</sub> = -1.0mA
ΔBV <sub>DSS</sub> /ΔT <sub>J</sub>	Breakdown Voltage Temp. Coefficient	—	-0.10	—	V/°C	Reference to 25°C, I <sub>D</sub> = -1.0mA
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance	—	—	0.30	Ω	V <sub>GS</sub> = -10V, I <sub>D2</sub> = -4.1A ④
		—	—	0.320		V <sub>GS</sub> = -10V, I <sub>D1</sub> = -6.5A ④
V <sub>GS(th)</sub>	Gate Threshold Voltage	-2.0	—	-4.0	V	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = -250μA
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	—	—	-25	μA	V <sub>DS</sub> = -80V, V <sub>GS</sub> = 0V
		—	—	-250		V <sub>DS</sub> = -80V, V <sub>GS</sub> = 0V, T <sub>J</sub> = 125°C
I <sub>GSS</sub>	Gate-to-Source Leakage Forward	—	—	-100	nA	V <sub>GS</sub> = -20V
	Gate-to-Source Leakage Reverse	—	—	100		V <sub>GS</sub> = 20V
Q <sub>G</sub>	Total Gate Charge	—	—	34.8	nC	I <sub>D1</sub> = -6.5A
Q <sub>GS</sub>	Gate-to-Source Charge	—	—	6.8		V <sub>DS</sub> = -50V
Q <sub>GD</sub>	Gate-to-Drain ('Miller') Charge	—	—	23.1		V <sub>GS</sub> = -10V
t <sub>d(on)</sub>	Turn-On Delay Time	—	—	60	ns	V <sub>DD</sub> = -40V
t <sub>r</sub>	Rise Time	—	—	140		I <sub>D1</sub> = -6.5A
t <sub>d(off)</sub>	Turn-Off Delay Time	—	—	140		R <sub>G</sub> = 7.5Ω
t <sub>f</sub>	Fall Time	—	—	140		V <sub>GS</sub> = -10V
L <sub>S</sub> + L <sub>D</sub>	Total Inductance	—	6.1	—	nH	Measured from the center of drain pad to center of source pad
C <sub>iSS</sub>	Input Capacitance	—	790	—	pF	V <sub>GS</sub> = 0V
C <sub>oSS</sub>	Output Capacitance	—	340	—		V <sub>DS</sub> = -25V
C <sub>rSS</sub>	Reverse Transfer Capacitance	—	71	—		f = 1.0MHz

### Source-Drain Diode Ratings and Characteristics

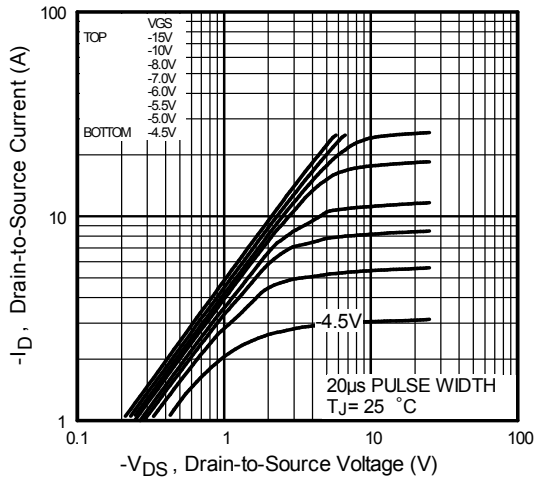
Symbol	Parameter	Min.	Typ.	Max.	Units	Test Conditions
I <sub>S</sub>	Continuous Source Current (Body Diode)	—	—	-6.5	A	
I <sub>SM</sub>	Pulsed Source Current (Body Diode) ①	—	—	-25		
V <sub>SD</sub>	Diode Forward Voltage	—	—	-4.3	V	T <sub>J</sub> = 25°C, I <sub>S</sub> = -6.5A, V <sub>GS</sub> = 0V ④
t <sub>rr</sub>	Reverse Recovery Time	—	—	250	ns	T <sub>J</sub> = 25°C, I <sub>F</sub> = -6.5A, V <sub>DD</sub> ≤ -50V
Q <sub>rr</sub>	Reverse Recovery Charge	—	—	3.0	μC	di/dt = -100A/μs ④
t <sub>on</sub>	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by L <sub>S</sub> +L <sub>D</sub> )				

### Thermal Resistance

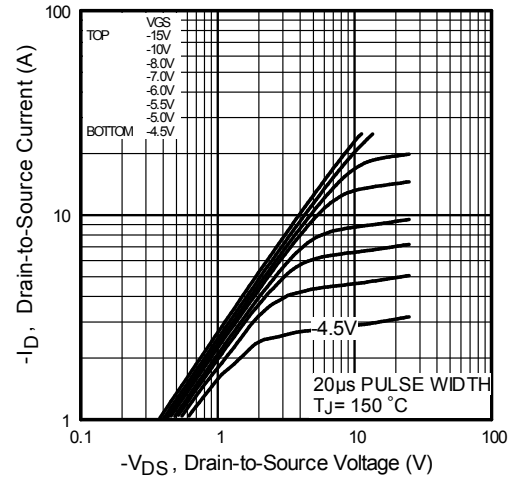
Symbol	Parameter	Min.	Typ.	Max.	Units
R <sub>θJC</sub>	Junction-to-Case	—	—	5.0	°C/W
R <sub>θJPCB</sub>	Junction-to-PC Board	—	—	19	

#### Footnotes:

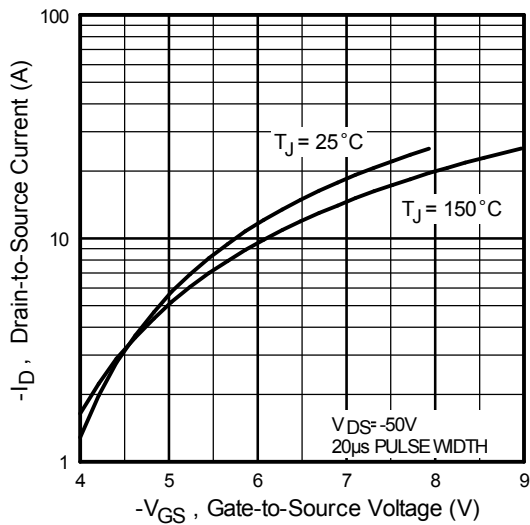
- ① Repetitive Rating; Pulse width limited by maximum junction temperature.
- ② V<sub>DD</sub> = -25V, starting T<sub>J</sub> = 25°C, Peak I<sub>L</sub> = -6.5A
- ③ I<sub>SD</sub> ≤ -6.5A, di/dt ≤ -390A/μs, V<sub>DD</sub> ≤ -100V, T<sub>J</sub> ≤ 150°C, Suggested R<sub>G</sub> = 7.5 Ω
- ④ Pulse width ≤ 300 μs; Duty Cycle ≤ 2%



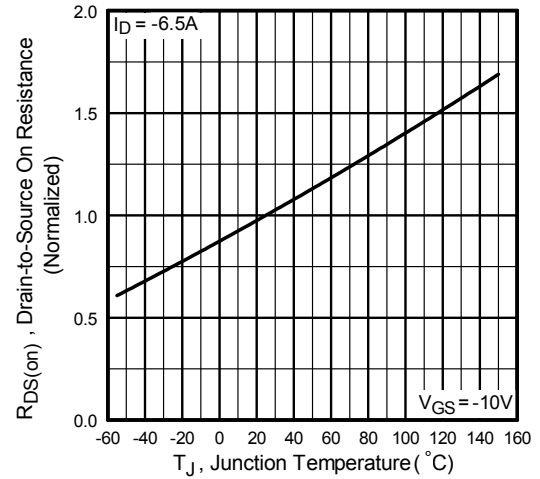
**Fig 1.** Typical Output Characteristics



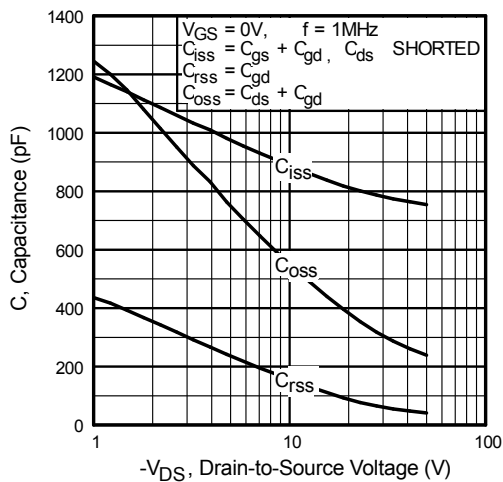
**Fig 2.** Typical Output Characteristics



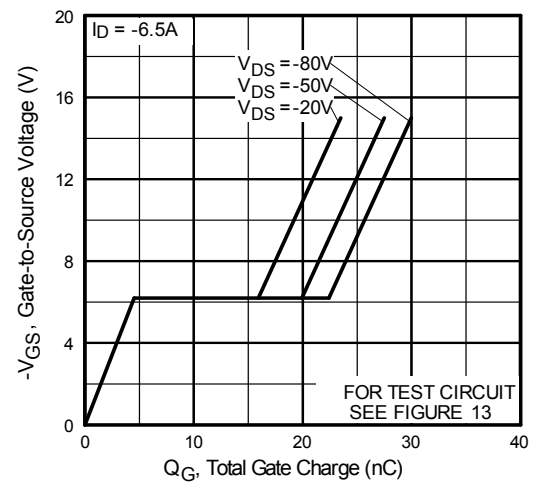
**Fig 3.** Typical Transfer Characteristics



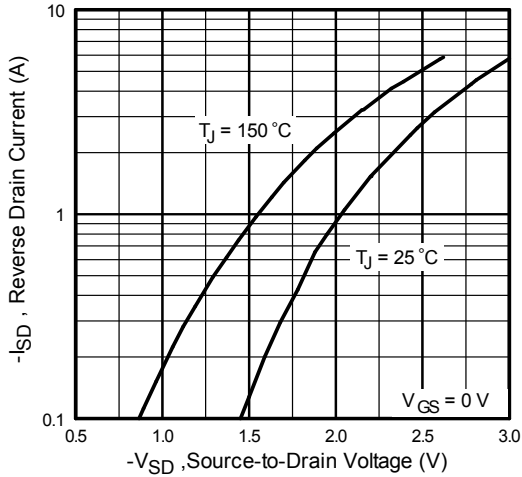
**Fig 4.** Normalized On-Resistance Vs. Temperature



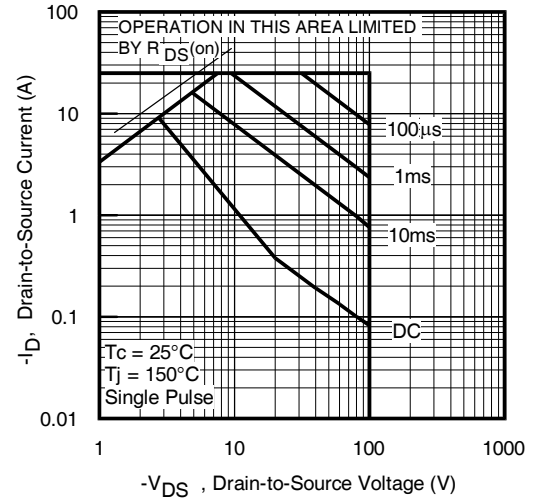
**Fig 5.** Typical Capacitance Vs. Drain-to-Source Voltage



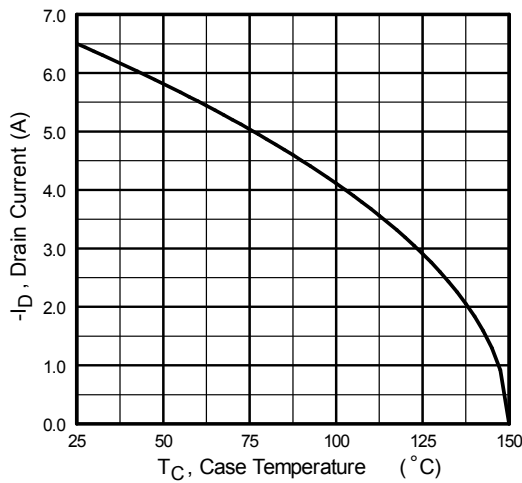
**Fig 6.** Typical Gate Charge Vs. Gate-to-Source Voltage



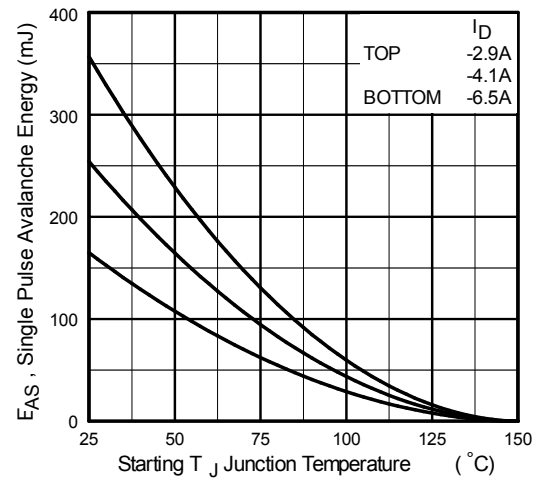
**Fig 7.** Typical Source-Drain Diode Forward Voltage



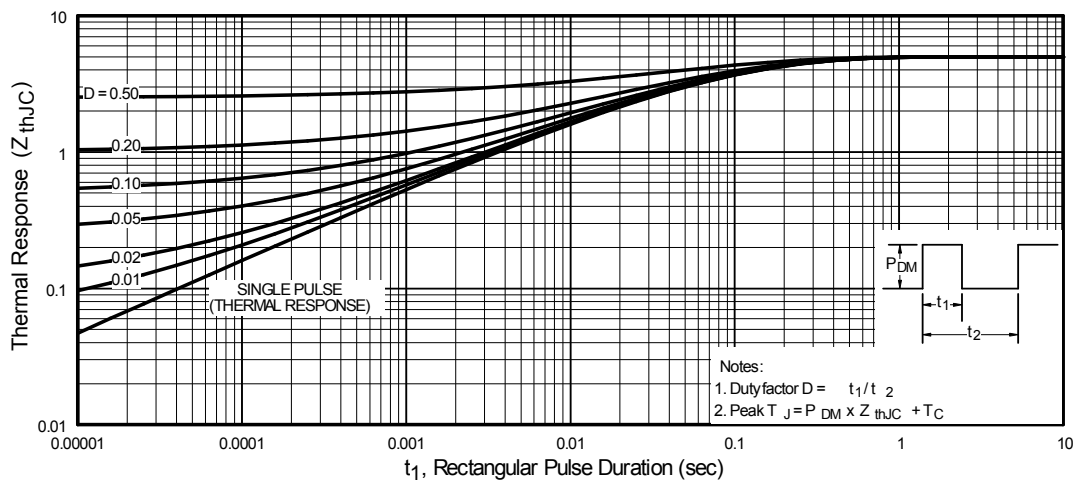
**Fig 8.** Maximum Safe Operating Area



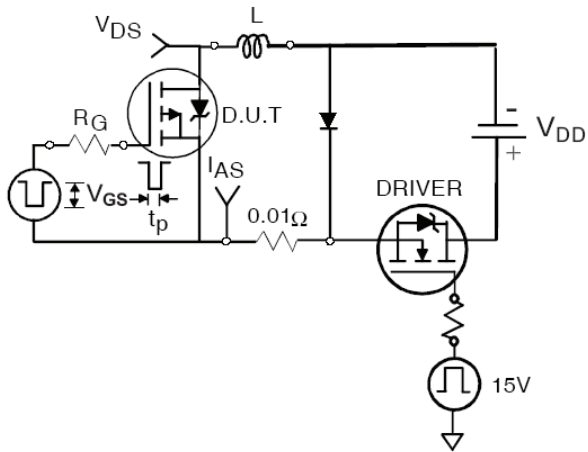
**Fig 9.** Maximum Drain Current Vs. Case Temperature



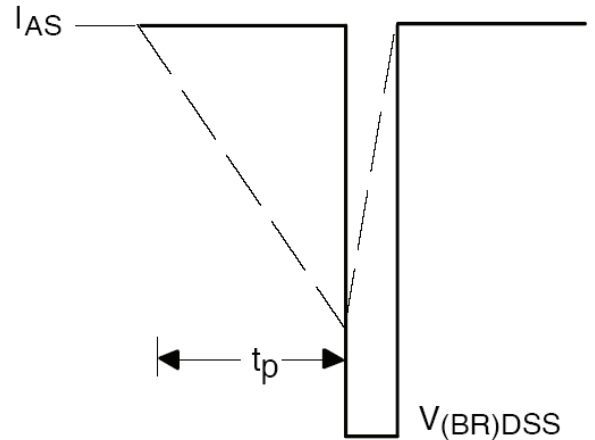
**Fig 10.** Maximum Avalanche Energy Vs. Drain Current



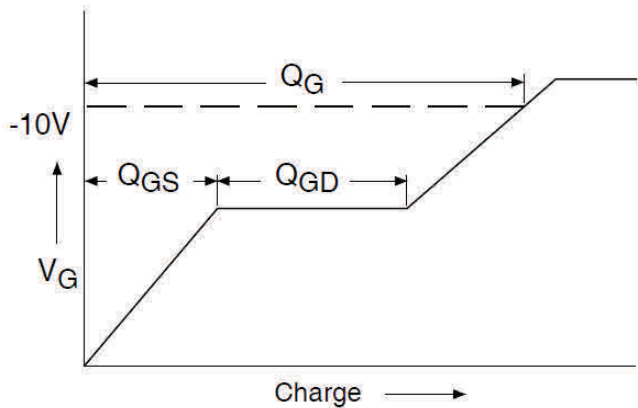
**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Case



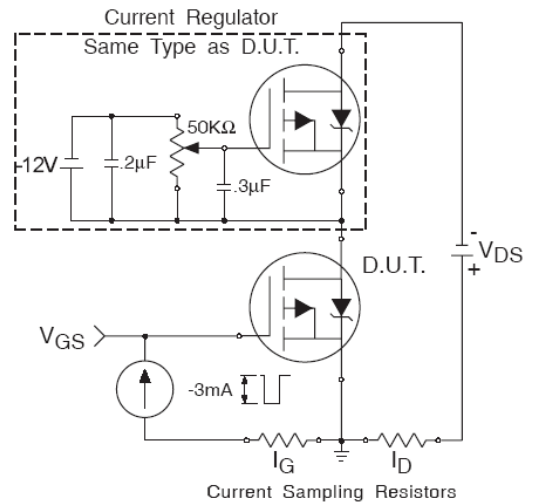
**Fig 12a.** Unclamped Inductive Test Circuit



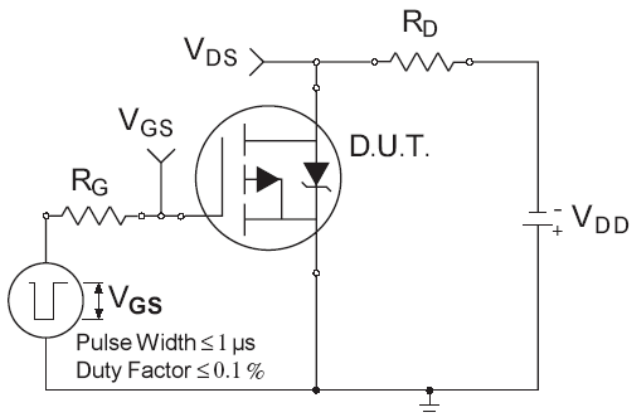
**Fig 12b.** Unclamped Inductive Waveforms



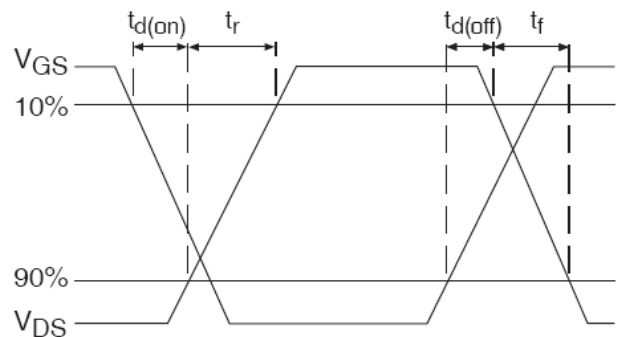
**Fig 13a.** Gate Charge Waveform



**Fig 13b.** Gate Charge Test Circuit

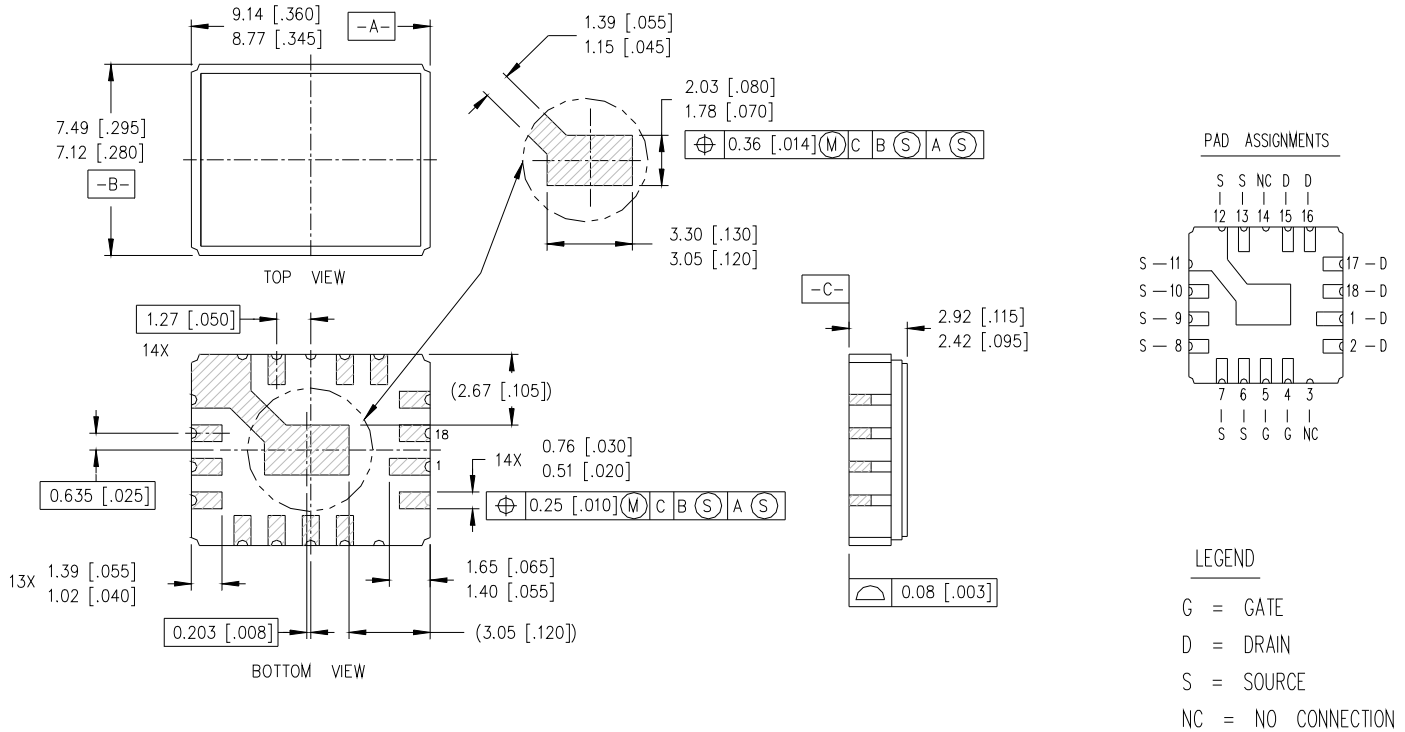


**Fig 14a.** Switching Time Test Circuit



**Fig 14b.** Switching Time Waveforms

**Case Outline and Dimensions - LCC-18**



**NOTES:**

1. DIMENSIONING & TOLERANCING PER ANSI Y14.5M-1982.
2. CONTROLLING DIMENSION: INCH.
3. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].

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